TOSHIBA Field Effect Transistor Silicon P-Channel MOS Type (U-MOS III)

TPCA8104

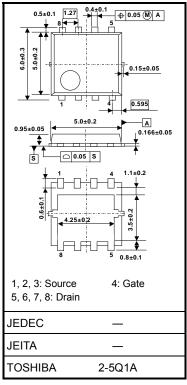
High-Side Switching Applications Portable Equipment Applications

- Small footprint due to small and thin package
- Low drain-source ON-resistance: RDS (ON) = 11 m Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 50 \text{ S (typ.)}$
- Low leakage current: $IDSS = -10 \mu A (VDS = -60 V)$
- Enhancement mode: $V_{th} = -0.8 \text{ to } -2.0 \text{ V (V}_{DS} = -10 \text{ V, I}_{D} = -1 \text{ mA)}$

Absolute Maximum Ratings (Ta = 25°C)

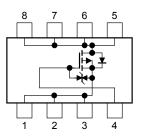
Characteristic			Symbol	Rating	Unit	
Drain-source voltage			V_{DSS}	-60	V	
Drain-gate vol	tage (R _{GS} =	= 20 kΩ)	V_{DGR}	-60	V	
Gate-source v	oltage		V _{GSS}	±20	V	
Drain current	DC	(Note 1)	I _D	-40	Α	
Diain current	Pulse	(Note 1)	` ' BI	-120	^	
Drain power dissipation (Tc = 25°C)			P _D	45	W	
Drain power dissipation (t = 10 s) (Note 2a)			P _D	2.8		
Drain power dissipation (t = 10 s) (Note 2b)			P _D	1.6		
Single-pulse avalanche energy (Note 3)			E _{AS}	116	mJ	
Avalanche current			I _{AR}	-40	Α	
Repetitive avalanche energy (Tc = 25°C) (Note 4)			E _{AR}	4.5	mJ	
Channel temperature			T _{ch}	150	°C	
Storage temperature range			T _{stg}	-55~150	°C	

Unit: mm



Weight: 0.080 g (typ.)

Circuit Configuration



Note: For Notes 1 to 4, see the next page.

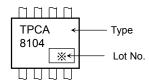
Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

This transistor is an electrostatic-sensitive device. Handle with care.

Thermal Characteristics

Characteristic	Symbol	Max	Unit	
Thermal resistance, channel to case (Tc = 25°C)	R _{th (ch-c)}	2.78	°C/W	
Thermal resistance, channel to ambient $(t = 10 \text{ s})$ (Note 2a)	R _{th (ch-a)}	44.6	°C/W	
Thermal resistance, channel to ambient (t = 10 s) (Note 2b)	R _{th (ch-b)}	78.1	C/VV	

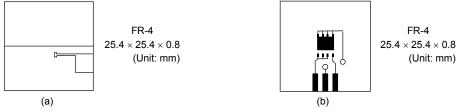
Marking (Note 5)



Note 1: The channel temperature should not exceed 150°C during use.

Note 2: (a) Device mounted on a glass-epoxy board (a)

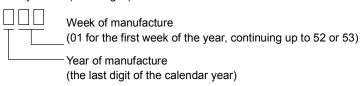
(b) Device mounted on a glass-epoxy board (b)



Note 3: $V_{DD} = -24~V$, $T_{ch} = 25^{\circ}C$ (initial), L = 0.1~mH, $R_G = 25~\Omega$, $I_{AR} = -40~A$

Note 4: Repetitive rating: pulse width limited by maximum channel temperature.

Note 5: * Weekly code (three digits):



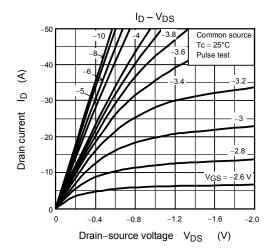
Electrical Characteristics (Ta = 25°C)

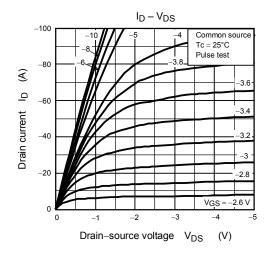
Cha	aracteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cur	rent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μA
Drain cutoff current		I _{DSS}	V _{DS} = -60 V, V _{GS} = 0 V	_	_	-10	μA
Drain-source breakdown voltage		V (BR) DSS	$I_D = -10 \text{ mA}, V_{GS} = 0 \text{ V}$	-60	_	_	V
		V (BR) DSX	$I_D = -10 \text{ mA}, V_{GS} = 20 \text{ V}$	-35	_	_	
Gate threshold vo	oltage	V _{th}	$V_{DS} = -10 \text{ V}, I_{D} = -1 \text{ mA}$	-0.8	_	-2.0	V
D: ONI		_	V _{GS} = -4 V, I _D = -20 A	_	17	24	
Drain-source ON-resistance		R _{DS (ON)}	V _{GS} = -10 V, I _D = -20 A	_	11	16	mΩ
Forward transfer admittance		Y _{fs}	$V_{DS} = -10 \text{ V}, I_{D} = -20 \text{ A}$	25	50		S
Input capacitance)	C _{iss}		_	4300	_	
Reverse transfer capacitance		C _{rss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	_	450	_	pF
Output capacitance		C _{oss}		_	600	_	
	Rise time	t _r	V_{GS} OV $I_{D} = -20A$ O	_	10	_	ns
	Turn-on time	t _{on}		_	20	_	
	Fall time	t _f		_	60	_	
	Turn-off time	t _{off}	Duty ≦ 1%, t _w = 10 μs	_	200	_	
Total gate charge (gate-source plus gate-drain)		Qg	V _{DD} ≈ -48 V, V _{GS} = -10 V	_	90	_	
Gate-source charge 1		Q _{gs1}	I _D = -40 A	_	16	_	nC
Gate-drain ("Miller") charge		Q _{gd}		_	28	_	

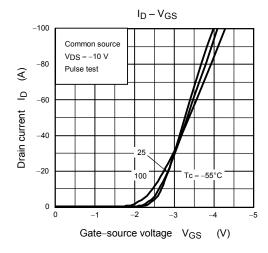
Source-Drain Ratings and Characteristics (Ta = 25°C)

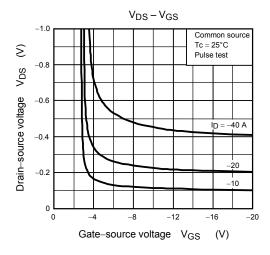
Characteristic		Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I _{DRP}	_	_	_	-120	Α
Forward voltage (diode)		V _{DSF}	I _{DR} = -40 A, V _{GS} = 0 V		_	1.2	V

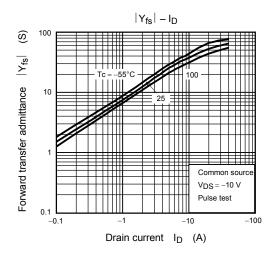
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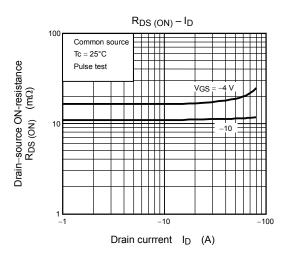




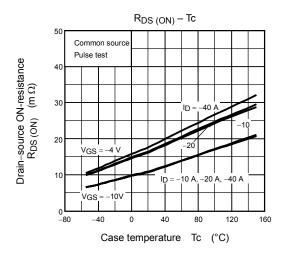


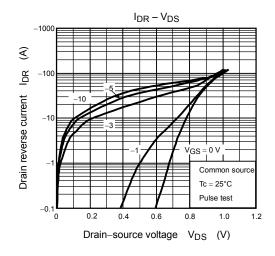


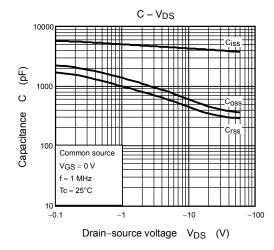


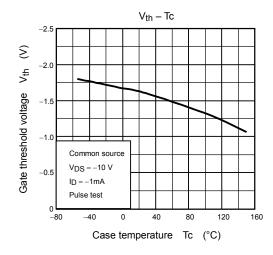


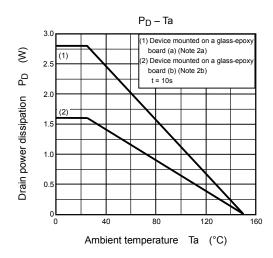
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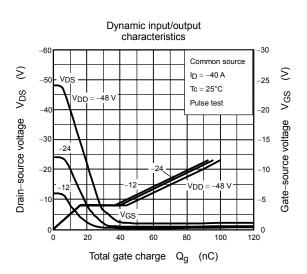


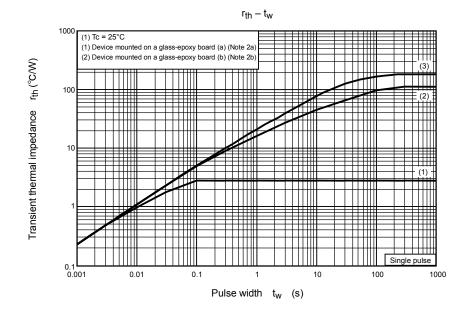


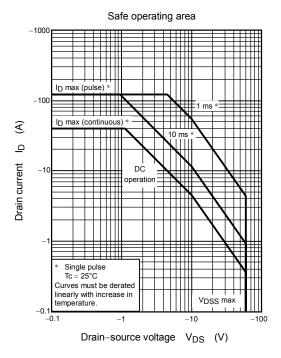


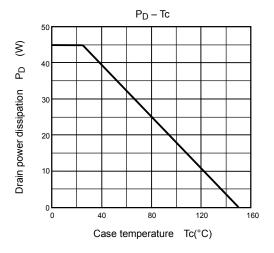












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